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# Laser processing of Li-doped mesoporous TiO<sub>2</sub> for ambient-processed mesoscopic perovskite solar cells†

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Mesoporous titanium dioxide (m-TiO<sub>2</sub>) has gained significant attention in photocatalytic, photo-electrochemical, energy storage, and photovoltaic applications. However, the performance of m-TiO<sub>2</sub>-based devices is often hindered by their poor electrical conductivity, low electron mobility, and high electronic trap density. Doping m-TiO<sub>2</sub> with alkali-metal elements is a promising method to tackle these issues. Herein, an ultrafast laser treatment is presented to introduce lithium (Li) doping into m-TiO<sub>2</sub> (Li-doped m-TiO<sub>2</sub>) to enhance its charge transport ability for mesoscopic perovskite solar cells (PSCs). Remarkably, the laser treatment only needs 42 s irradiation in total at the highest temperature of 800–850 °C to prepare the Li-doped m-TiO<sub>2</sub>, compared to the traditional furnace treatment at a temperature of 500 °C for 60 min. Consequently, PSCs assembled under high relative humidity (60–75%) using the laser treatment exhibited a power conversion efficiency (PCE) of 19.15%, higher than that of the furnace treatment of 18.10%. The improvement is due to the enhanced interconnection between the Li-doped m-TiO<sub>2</sub> nanoparticles, reduced oxygen vacancies, and improved interfacial contact at m-TiO<sub>2</sub>/perovskite, resulting from the laser treatment. These factors contribute to an improved electron transport capability, reduced charge recombination, and suppressed hysteresis behaviour in the PSCs. The ultrafast laser treatment introduced here offers a novel path for rapid manufacturing of metal-doped m-TiO<sub>2</sub> materials for PSCs and other related applications.

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## 1. Introduction

Mesoporous titanium dioxide (m-TiO<sub>2</sub>) materials have been widely used in many emerging applications, including photocatalytic hydrogen generation and degradation of pollutants, photoelectrochemical water splitting, lithium batteries, dye-sensitized solar cells (DSSCs) and perovskite solar cells (PSCs).<sup>1,2</sup>

For PSCs, m-TiO<sub>2</sub>, serving as an n-type semiconductor, has been extensively employed as the electron transport layer (ETL) in mesoscopic structure devices owing to its thermal and chemical stabilities, low toxicity, cost-effectiveness and favourable energy band alignment.<sup>3,4</sup>

However, as the ETL, the m-TiO<sub>2</sub> faces challenges such as relatively poor electrical conductivity, high electronic trap density and low electron mobility. Thus, the PSCs based on the m-TiO<sub>2</sub> are limited in their performance.<sup>5,6</sup> One promising approach to tackling these issues is to dope m-TiO<sub>2</sub> with appropriate dopants. To date, numerous metal elements have been investigated as the dopants for m-TiO<sub>2</sub> to enhance its charge transport ability for efficient PSCs, such as lithium (Li),<sup>5,7</sup> tantalum (Ta),<sup>8</sup> niobium (Nb),<sup>9</sup> tin (Sn),<sup>10</sup> zinc (Zn),<sup>11</sup> aluminium (Al),<sup>12</sup> europium (Eu),<sup>13</sup> neodymium (Nd)<sup>14</sup> and cobalt (Co).<sup>15</sup> Among these, Li has been one of the most widely used dopants due to its remarkable improvement in charge transport ability and significant reduction of defects in the m-TiO<sub>2</sub>.<sup>5,7</sup> Several studies have achieved highly efficient PSCs using Li-doped m-TiO<sub>2</sub>.<sup>16–19</sup>

Conventional methods for fabricating Li-doped m-TiO<sub>2</sub> commonly involve time-consuming heating processes using a

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furnace or oven. Briefly, the m-TiO<sub>2</sub> paste combined with a compact TiO<sub>2</sub> (c-TiO<sub>2</sub>) layer is sintered in a furnace or oven at 450–550 °C for over 30 min to ensure that the organic binders are evaporated, and the TiO<sub>2</sub> nanoparticles are interconnected. Subsequently, the resultant m-TiO<sub>2</sub> films are spin-coated with the Li-salt precursor and then treated again at over 450 °C for 30 to 60 min to induce the doping.<sup>16–19</sup> Considering the cooling process after the heating treatment, the overall processing time can take up to several hours. Similar treatments are employed for doping other metal elements into m-TiO<sub>2</sub>.<sup>20,21</sup> Such a time-consuming fabrication process presents challenges for the high throughput production of mesoscopic PSCs. In addition, these conventional methods with prolonged high-temperature processing time could lead to the bending of glass substrates.<sup>22,23</sup> Therefore, developing highly efficient processing methods for manufacturing metal-doped m-TiO<sub>2</sub> is essential.

Alternative methods to fabricate doped m-TiO<sub>2</sub> for PSCs have only been investigated in a few studies. Recently, a rapid flame annealing process was employed to fabricate Co-doped m-TiO<sub>2</sub> films.<sup>15</sup> The researchers spin-coated the m-TiO<sub>2</sub> paste on top of the pre-deposited c-TiO<sub>2</sub> film, and after that, annealing at 500 °C for 0.5–1 h is performed to fabricate m-TiO<sub>2</sub>. The m-TiO<sub>2</sub> was then immersed in the solution containing Co-salt and treated with the flame annealing process at 1000 °C for 40 s to complete the fabrication of Co-doped m-TiO<sub>2</sub>. They proposed that the high heating/cooling rates of the flame doping method enabled the introduction of a high concentration of Co<sup>2+</sup> doping into m-TiO<sub>2</sub> in a short period without damaging the m-TiO<sub>2</sub> structure and glass substrate. Additionally, they reported that high temperatures ( $\approx$ 1000 °C) could evaporate the binders in the m-TiO<sub>2</sub> paste more completely and promote interconnections between the TiO<sub>2</sub> nanoparticles.<sup>24</sup> Our recent study has also presented a rapid laser process to induce the crystallisation of c-TiO<sub>2</sub> for planar PSCs from amorphous to anatase phase, as well as to introduce Ta doping into c-TiO<sub>2</sub> film.<sup>25,26</sup> However, to our knowledge, there have been no reported studies on the utilisation of laser treatment for the fabrication of metal-doped m-TiO<sub>2</sub>. In addition, due to the large surface area and tunable porosity, metal-doped m-TiO<sub>2</sub> has been widely used in the field of photocatalytic water splitting,<sup>27</sup> degradation of pollutants and organic dyes,<sup>28</sup> energy storage,<sup>29</sup> biosensing,<sup>30</sup> antibacterial applications.<sup>31</sup> Therefore, developing a rapid and scalable method to process metal-doped m-TiO<sub>2</sub> will potentially contribute not only to the perovskite community but also to a broader audience in the related fields engaged with using metal-doped m-TiO<sub>2</sub>.

Herein, we present an ultrafast laser processing method to prepare the Li-doped m-TiO<sub>2</sub> films for mesoscopic PSCs assembled under a relative humidity (RH: 60–75%), as shown in Fig. S1 (ESI<sup>†</sup>) with a humidity meter displaying an RH of 72.8%. High-quality Li-doped m-TiO<sub>2</sub> films can be fabricated by optimising laser processing parameters *via* a total irradiation time of 42 s with a laser processing temperature of 800–850 °C. To examine differences resulting from various treatments and Li doping, we conducted systematic materials and chemical characterisations on the laser- and furnace-treated Li-doped m-TiO<sub>2</sub> and undoped m-TiO<sub>2</sub>, including ultraviolet-visible-near-infrared

(UV-VIS-NIR), Raman, scanning electron microscopy (SEM), X-ray diffraction (XRD) analysis, atomic force microscopy (AFM), X-ray photoelectron (XPS) and ultraviolet photoelectron (UPS) spectroscopies. Furthermore, we performed photoelectric, electric and photovoltaic measurements, including power conversion efficiency (PCE), photo-current decay (TPC), space-charge-limited current (SCLC), photo-voltage decay (TPV), steady-state photoluminescence (PL), time-resolved PL (TRPL), electrochemical impedance spectroscopy (EIS) and external quantum efficiency (EQE) to investigate the differences in charge transport ability, recombination and trap density for m-TiO<sub>2</sub> films prepared by different treatment methods.

## 2. Experimental section

### 2.1. Materials

Hellmanex III detergent was purchased from Alfa Aesar. Pre-patterned ITO substrates, spiro-OMeTAD (99.0%) and formamidinium iodide (FAI; 98%) were purchased from Ossila LTD. Titanium diisopropoxide bis(acetylacetonate) (75 wt% in isopropanol), 1-butanol (99.8%), lead iodide (PbI<sub>2</sub>, 99.9985%), cesium iodide (CsI; 99.999%), lithium carbonate (Li<sub>2</sub>CO<sub>3</sub>, 99.99%), ethyl acetate (99.8%), dimethylformamide (DMF; 99.8%), dimethyl sulfoxide (DMSO; 99.9%), 4-*tert*-butylpyridine (TBP; 98%), bis(trifluoromethane)sulfonimide lithium salt (LiTFSI; 99.95%), chlorobenzene (99.9%) and acetonitrile (99.8%) were purchased from Sigma-Aldrich. TiO<sub>2</sub> paste (Dyesol, 18NR-T) was obtained from the Great solar cell. Pre-patterned FTO substrates were purchased from Advanced Election Technology Co., Ltd.

### 2.2. Preparation of Li-doped m-TiO<sub>2</sub>

**2.2.1. Furnace treatment.** ITO and FTO substrates were cleaned in an ultrasonic bath with 3% Hellmanex solution, followed by rinsing ultrasonically in deionized water and ethanol. Afterwards, the cleaned substrates were treated with UV-ozone for 15 min. The c-TiO<sub>2</sub> and m-TiO<sub>2</sub> films were prepared and spin-coated according to the procedures detailed in our previous studies.<sup>32,33</sup> The films were then annealed in a muffle furnace with a temperature of 500 °C for 30 min. For Li-doped m-TiO<sub>2</sub>, deionised water was used to dissolve various amounts of Li<sub>2</sub>CO<sub>3</sub> to obtain the Li-salt solution with varied concentrations (0.5, 1.0, 1.5 mg mL<sup>-1</sup>). Then, these Li-salt solutions were dropped on the m-TiO<sub>2</sub> films and spin-coated at 4000 rpm for 30 s. After that, these films were annealed again in a muffle furnace with a temperature of 500 °C for 30 min to fabricate Li-doped m-TiO<sub>2</sub>.

**2.2.2. Laser treatment.** An IPG fibre laser (1070 nm) was employed for the laser treatment of Li-doped m-TiO<sub>2</sub> films, and the laser beam was defocused to obtain a spot size with a diameter of  $\sim$ 5 cm. A FLIR thermal camera recorded the temperature changes during the laser process. After spin-coating c-TiO<sub>2</sub> and m-TiO<sub>2</sub> films on the ITO and FTO substrates, the films were exposed to laser irradiation. The laser power densities of 113 W cm<sup>-2</sup> were utilized, with irradiation



durations of 14, 18, and 22 s to reach the highest annealing temperatures of 700–750, 800–850, and 900–950 °C, respectively. To maintain the substrates at the highest annealing temperatures, the laser power densities were then adjusted to 36 W cm<sup>-2</sup>, respectively, and kept for 3 s after reaching the highest annealing temperatures to complete fabrication of m-TiO<sub>2</sub>. Subsequently, 1.0 mg mL<sup>-1</sup> Li<sub>2</sub>CO<sub>3</sub> solution was used to treat the m-TiO<sub>2</sub> films, followed by the same laser irradiation process to complete Li-doped m-TiO<sub>2</sub> fabrication.

### 2.3. Device fabrication

The Cs<sub>0.1</sub>FA<sub>0.9</sub>PbI<sub>3</sub> perovskite film was prepared by the following step: Initially, 460 mg of PbI<sub>2</sub> were dissolved in 1 mL mixture of DMSO and DMF (1:4), followed by stirring at 65 °C for 1 h. After cooling down to room temperature, a total of 26 mg of CsI and 155 mg of FAI were introduced to the solution and then thoroughly stirred by the magic stir overnight to obtain the perovskite precursor. Subsequently, 100 μL of the perovskite precursor was dropped on the m-TiO<sub>2</sub> or Li-doped m-TiO<sub>2</sub>, followed by two spin coating programs of 1000 rpm for 10 s for 1st step and 4000 rpm for 30 s for 2nd step. Ethyl acetate (200 μL) was dropped on the substrate at the 20th second of the 2nd step. Lastly, the perovskite film was annealed on a hot plate at 100 °C for 10 min.

The spiro-MeOTAD solution was prepared by using 86 mg spiro-MeOTAD dissolved in 1 mL chlorobenzene, followed by adding 30 μL 4-*tert*-butyl pyridine and 20 μL of Li-TSFI (520 mg in 1 mL acetonitrile). 80 μL of this solution was then dynamically spin-coated onto the perovskite film at a speed of 4000 rpm. Finally, a 100 nm Au electrode was deposited on top of perovskite films by a thermal evaporator.

### 2.4. Material and device characterisation

The surface morphology of undoped TiO<sub>2</sub> and Li-doped m-TiO<sub>2</sub> films and perovskite films were observed by a field-emission scanning electron microscope Ultra-55, Carl Zeiss. UV-Vis-NIR spectra were measured by Shimadzu UV-2401PC spectrophotometer. XRD patterns were obtained by a PANalytical XRD2 diffractometer. Photovoltaic performance was measured with an Oriel solar simulator with a masking active area of 2.4 mm<sup>2</sup>. The water contact angle was measured using an FTA188 analyzer. The surface roughness was analysed using a Bruker Multimodal 8 AFM, respectively. The TPV and TPC were examined with a solid-state laser diode (DL5146-101S) with a wavelength of 405 nm as the light source, controlled by a Thorlabs LDC205C laser controller and TED200C temperature controller. A square wave modulation of the light was achieved through an Agilent 33220A function generator and an acousto-optic modulator (Gooch & Housego, M080). The modulation frequencies were selected based on the transient decay times, with photovoltage decay measurements using 0.1 Hz, and photocurrent measurements using 1000 and 4000 Hz frequencies. The transient signal was collected by a Keysight DSOS604A digital storage oscilloscope. For photocurrent measurements, the oscilloscope was connected across a resistor (1000 ohms). The PL and TRPL spectra were obtained by an FLS980 spectrometer (Edinburgh

Instruments). Resistance of the ITO electrodes was measured using a two-probe technique, and the surface chemistry and energy diagram were obtained by a Kratos Axis XPS. EIS was recorded under the dark condition with a 10 mV signal and a 0.9 V bias applied at a frequency range from 100 Hz to 100 K Hz for measurement.

## 3. Results and discussion

To find the optimised doping concentration of Li in m-TiO<sub>2</sub>, we assembled devices using m-TiO<sub>2</sub> doped with various concentrations of Li-salt (Li<sub>2</sub>CO<sub>3</sub>) as ETL. The PSCs were fully prepared in ambient air condition except for the fabrication of the Au electrode, the relative humidity (RH: 60–75%) is presented in Fig. S1 (ESI<sup>†</sup>). We use ethyl acetate as a green antisolvent to facilitate crystallisation of the perovskite layers in a one-step deposition process, as reported in our previous works.<sup>32–34</sup> Fig. 1a shows a schematic structure of the PSCs: ITO-glass/c-TiO<sub>2</sub>/m-TiO<sub>2</sub>/perovskite/Spiro-OMeTAD/Au. PCE distribution and representative *J*-*V* curves for the PSCs using undoped m-TiO<sub>2</sub> and Li-doped m-TiO<sub>2</sub> with different concentrations of Li-salt as ETL are shown in Fig. 1b and c, respectively. The detailed photovoltaic parameters are presented in Table S1 (ESI<sup>†</sup>). The average PCEs for devices based on the undoped m-TiO<sub>2</sub> films is 17.16% with a *J*<sub>sc</sub> of 23.22 mA cm<sup>-2</sup>, *V*<sub>oc</sub> of 1.010 mV and FF of 73.19%. We observed that the PCE increases with adding Li-salt and reaches a maximum average PCE of 17.74% with a concentration of 1.0 mg mL<sup>-1</sup> but decreases with a higher concentration of 1.5 mg mL<sup>-1</sup>. Besides, the distributions of *J*<sub>sc</sub>, *V*<sub>oc</sub> and FF for devices with the undoped m-TiO<sub>2</sub> and Li-doped m-TiO<sub>2</sub> are displayed in Fig. S2a–c (ESI<sup>†</sup>). The PCE trends and counts distribution of the PSCs with undoped m-TiO<sub>2</sub> and Li-doped m-TiO<sub>2</sub> (1.0 mg mL<sup>-1</sup>) are shown in Fig. 1d. According to previous studies, the improvement based on the Li-doped m-TiO<sub>2</sub> could be attributed to the improved electrical conductivity and electron mobility and reduced electronic trap states.<sup>5,35</sup> The decrease of the PCEs of PSCs with a higher doping concentration of Li-salt could be caused by undesired electronic trap states introduced by the excessive Li dopants, which has a detrimental impact on the charge carrier transport.<sup>36</sup>

Having determined the optimal doping concentration of 1.0 mg mL<sup>-1</sup> Li-salt to the m-TiO<sub>2</sub>, we then utilised an ultrafast laser processing method to evaporate the organic binders and introduce the Li doping into m-TiO<sub>2</sub>. As demonstrated in Fig. 2a, the laser treatment consists of two steps. The first step is to irradiate the m-TiO<sub>2</sub> paste and compact TiO<sub>2</sub> precursor film coated on the ITO substrate or FTO substrate for 21 s to evaporate binders, induce necking among the TiO<sub>2</sub> nanoparticles, and crystallise compact TiO<sub>2</sub> films. The second step is to irradiate the m-TiO<sub>2</sub> infiltrated with the Li-salt for 21 s to induce the Li doping in m-TiO<sub>2</sub>. The laser processing setup was modified based on our previous work.<sup>25,26,37</sup> The laser setup and detailed parameters are described in the experimental section and Table S2 (ESI<sup>†</sup>). As shown in Fig. 2b, an FTIR



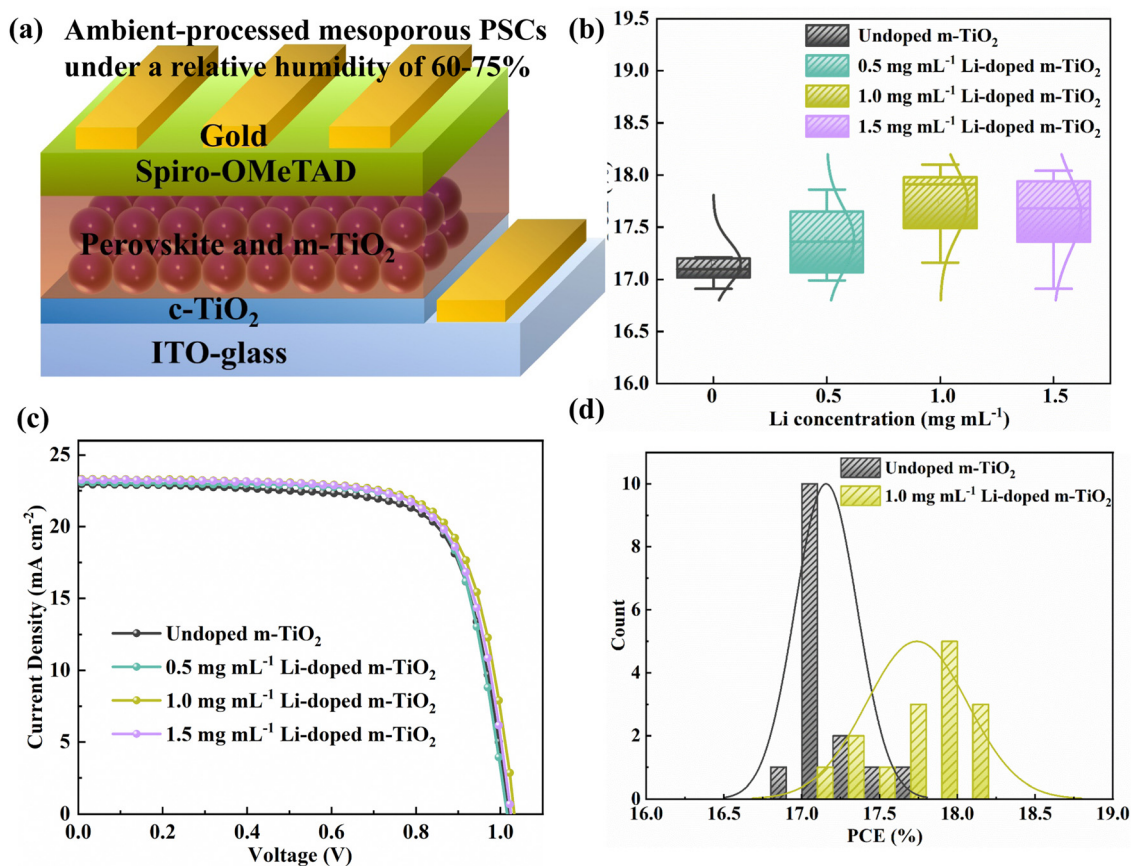


Fig. 1 (a) Schematics representation for the ambient-processed mesoscopic PSCs under a RH of 60-75%. (b) PCE distribution and (c) representative J-V curves for PSCs based on the undoped m-TiO<sub>2</sub> and Li-doped TiO<sub>2</sub>. (d) PCE and counts distribution for the PSCs based on the undoped TiO<sub>2</sub> and Li-doped m-TiO<sub>2</sub> (1.0 mg mL<sup>-1</sup>).

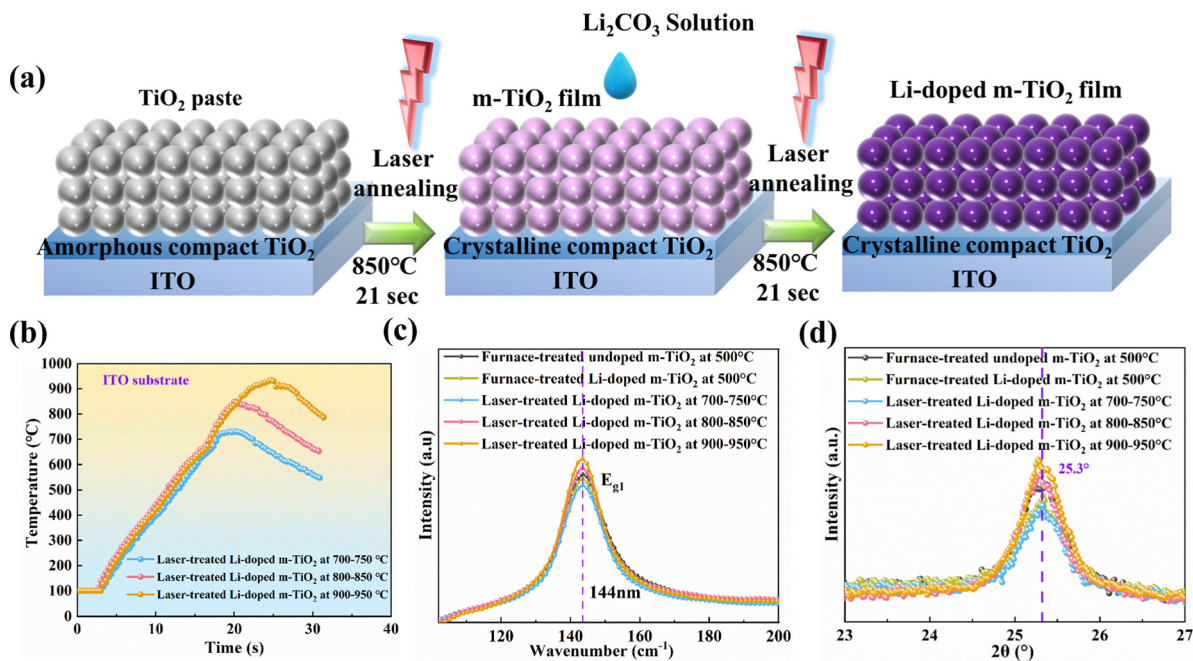


Fig. 2 (a) Schematic representation for the Li-doped m-TiO<sub>2</sub> prepared by the laser treatment. (b) Temperature profiles for the Li-doped m-TiO<sub>2</sub> films coated on ITO substrate measurement during laser treatments. (c) Raman spectra and (d) XRD patterns for the furnace-treated undoped m-TiO<sub>2</sub>, Li-doped m-TiO<sub>2</sub> and laser-treated Li-doped m-TiO<sub>2</sub> films.



thermal camera was employed to capture temperature changes of m-TiO<sub>2</sub> on the ITO substrate treated by different laser programs. Highest annealing temperatures of around 700–750, 800–850, and 900–950 °C were obtained based on three sets of laser parameters. The corresponding thermal images are shown in Fig. S3 (ESI†).

Raman spectroscopy was conducted to study the crystallinity of the Li-doped m-TiO<sub>2</sub> fabricated by conventional method and laser method, as displayed in Fig. S4a (ESI†). All the m-TiO<sub>2</sub> films showed peaks at 144, 399, 519 and 639 cm<sup>-1</sup>, which indicate that TiO<sub>2</sub> films exhibit an anatase phase. The Raman peak at 144 cm<sup>-1</sup> ( $E_{g1}$ ) associated with anatase TiO<sub>2</sub> are further zoomed in, as shown in Fig. 2c. The peak intensity for  $E_{g1}$  decreases after introducing the Li doping into m-TiO<sub>2</sub> compared to the undoped m-TiO<sub>2</sub>. This is due to the presence of Li<sup>+</sup> at the interstitial position of the TiO<sub>2</sub> lattice that reduces the Ti<sup>4+</sup> to Ti<sup>3+</sup>, resulting in a change of the Raman peak intensity.<sup>38</sup> We also noticed that the peak intensity at 144 cm<sup>-1</sup> ( $E_{g1}$ ) increases with increasing laser annealing temperature, indicating that the crystallinity of the TiO<sub>2</sub> film is improved and TiO<sub>2</sub> nanoparticles are better necked.<sup>39</sup> In addition, the phase transition temperature for TiO<sub>2</sub> from anatase to the rutile phase usually happens between 600 °C to 700 °C.<sup>40</sup> Nevertheless, no rutile phase has been detected for all laser-treated samples. We believe the short laser processing time (<25 s) contributes to the anatase phase for all these m-TiO<sub>2</sub>, even with the highest annealing temperatures up to 700–950 °C.

XRD analysis is performed to further investigate the impact of laser treatment on the crystallinity of Li-doped m-TiO<sub>2</sub>. Fig. S4b (ESI†) shows the XRD patterns of undoped m-TiO<sub>2</sub> films and Li-doped m-TiO<sub>2</sub> prepared by furnace process and laser process. The XRD confirmed that all these undoped and Li-doped m-TiO<sub>2</sub> exhibit the anatase phase, as shown in Fig. 2d. The anatase phase (101) shows a slightly decreased peak intensity after introducing the Li doping compared to the undoped m-TiO<sub>2</sub>. This might be attributed to the larger ion radius of Li<sup>+</sup> (76.0 pm) substituting for the Ti<sup>4+</sup> (60.5 pm), causing the distortion of the crystal lattice. Notably, no rutile phase peak is observed in all these m-TiO<sub>2</sub> films, which is consistent with the Raman study. In addition, the intensity of (101) peaks increase with increasing laser annealing temperature. The full width at half-maximum (FWHM) for furnace-treated undoped, Li-doped m-TiO<sub>2</sub> and laser-treated Li-doped m-TiO<sub>2</sub> with the highest annealing temperature of 700–750 °C, 800–850 °C and 900–950 °C are calculated to be 0.638°, 0.653°, 0.726°, 0.628° and 0.617°, respectively. The crystal sizes of m-TiO<sub>2</sub> are calculated using the Scherrer equation, summarised in Table S3 (ESI†). We noticed that the crystal size enlarges with the laser processing temperature. The Li-doped m-TiO<sub>2</sub> samples treated by laser with the highest annealing temperature of 800–850 °C and 900–950 °C showed larger crystal sizes and smaller FWHM than the furnace-treated sample. We believe that the high annealing temperature achieved by the laser process enhances the necking among TiO<sub>2</sub> nanoparticles and improves the film's crystallinity,<sup>41</sup> which is consistent with the Raman results. This finding also agrees with

the previous study on using flame annealing (around 1000 °C) to treat the m-TiO<sub>2</sub> to improve the interconnection between the TiO<sub>2</sub> nanoparticles.<sup>24</sup>

UV-Vis-NIR spectroscopy was performed to investigate the optical properties of the Li-doped m-TiO<sub>2</sub> films. As shown in Fig. 3a, we noticed that the laser-treated Li-doped m-TiO<sub>2</sub> exhibits higher optical transmission than the furnace-treated samples at wavelengths from 350 to 450 nm, which could improve the perovskite layer's light absorption, resulting in better photovoltaic performance. The optical band gaps ( $E_{bg}$ ) of the samples could be obtained from the absorption spectra. The band gap of furnace-treated undoped m-TiO<sub>2</sub>, Li-doped m-TiO<sub>2</sub> and laser-treated Li-doped m-TiO<sub>2</sub> films (800–850 °C) are 3.37 eV, 3.38 eV, and 3.40 eV, respectively, as shown in Fig. S5a–c (ESI†).

To study the energy band structure of m-TiO<sub>2</sub> films processed by furnace and laser method, UPS was carried out. The magnified valence band edge ( $E_{on-set}$ ) acquired from UPS measurement is shown on the left side of Fig. 3b. The secondary electron cutoff edge ( $E_{cut-off}$ ) is shown on the right side. The Fermi level ( $E_F$ ) is obtained through an equation:  $E_F = E_{cut-off} + 18.99 \text{ eV} - 40.8 \text{ eV}$ , where 18.99 eV refers to the bias voltage energy and 40.8 eV refers to the photo energy of He II. The valence band maximum ( $E_{VBM}$ ) is derived through an equation:  $E_{VBM} = E_F - E_{on-set}$ . Combined with the band gap from UV-visible measurement, the conduction band minimum ( $E_{CBM}$ ) could be calculated based on  $E_{CBM} = E_{VBM} + E_g$ .<sup>42</sup> The  $E_{VBM}$  of furnace-treated undoped m-TiO<sub>2</sub>, Li-doped m-TiO<sub>2</sub> and laser-treated Li-doped m-TiO<sub>2</sub> films (800–850 °C) were calculated to be -7.41, -7.47 and -7.48 eV, respectively. Also, the  $E_{CBM}$  were calculated to be -4.04 eV, -4.09 eV and -4.08 eV, respectively. The energy level diagram and carrier extraction mechanism of ETL and the perovskite film are displayed in Fig. 3c, and the values are concluded in Table S4 (ESI†). Introducing Li doping into m-TiO<sub>2</sub> improves the conduction band alignment between the m-TiO<sub>2</sub> and perovskite film. A better band alignment could reduce charge accumulation and recombination, improving charge transport between m-TiO<sub>2</sub> and perovskite. A relatively lower  $E_{VBM}$  for the Li-doped m-TiO<sub>2</sub> than undoped m-TiO<sub>2</sub> could be more efficient in blocking holes and suppressing charge recombination.

XPS was conducted to study the elemental composition and surface chemistry changes for undoped and Li-doped m-TiO<sub>2</sub> films processed by different treatments. Fig. 4a shows XPS survey spectra and Fig. S6 (ESI†) shows XPS spectra for the Ti 2p<sub>3/2</sub> (458.8 eV) and 2p<sub>1/2</sub> (464.5eV), corresponding to Ti<sup>4+</sup>. There is no noticeable change for the Ti 2p<sub>3/2</sub> and 2p<sub>1/2</sub> peaks before and after introducing Li doping. However, the O 1s located at 530.0 eV for the furnace- and laser-treated Li-doped m-TiO<sub>2</sub> shows a noticeable shoulder located at the higher binding energy next to the main peak due to oxygen interaction with the Li, compared to the furnace-treated undoped m-TiO<sub>2</sub> as shown in Fig. 4b, in good agreement with the previous studies.<sup>5,35,43</sup> The area ratio between the shoulder and main peak for the furnace-treated undoped m-TiO<sub>2</sub>, furnace- and laser-treated Li-doped m-TiO<sub>2</sub> films is calculated to be 0.26,



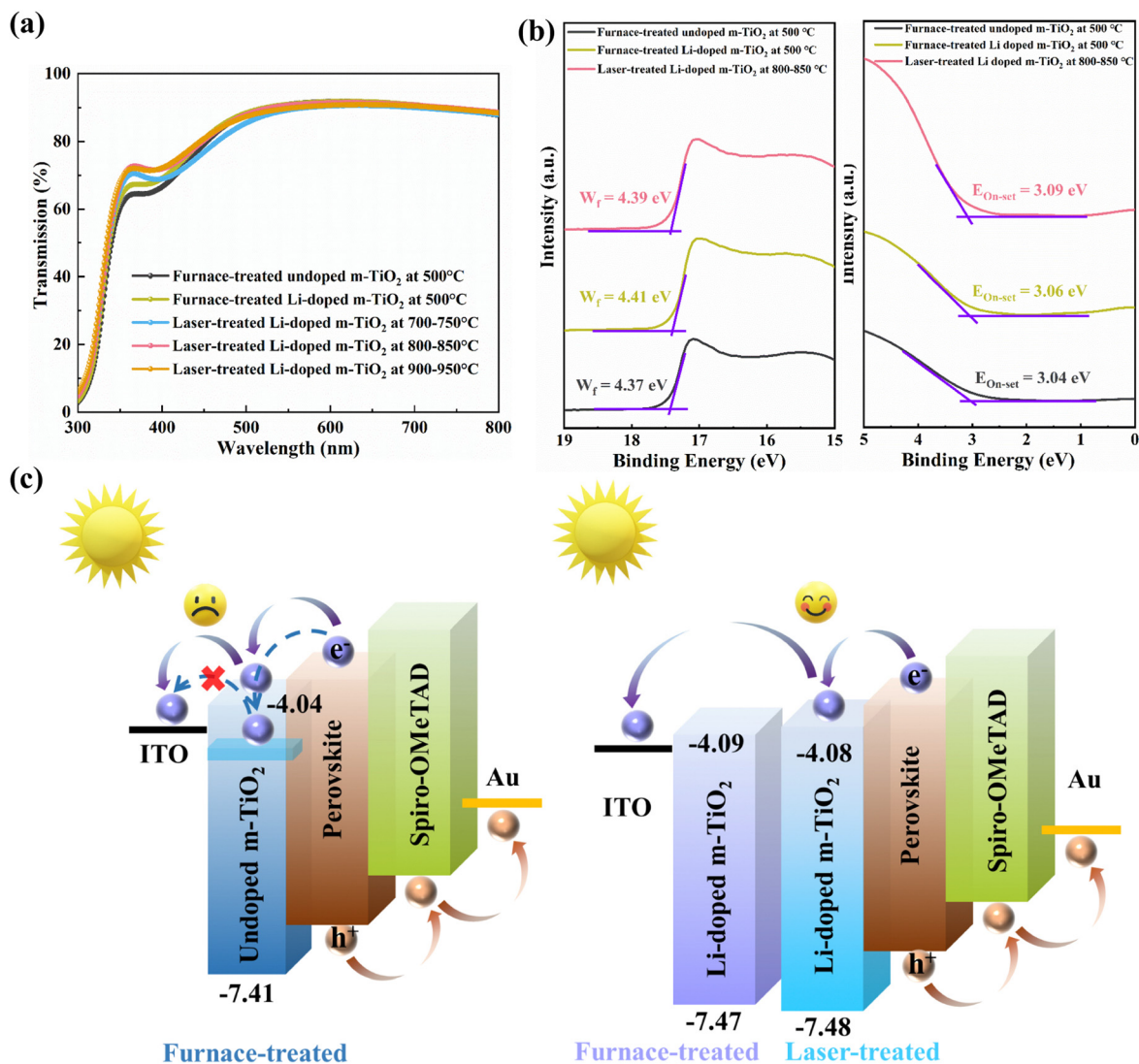


Fig. 3 (a) UV-Vis-NIR transmission spectra for the furnace-treated undoped m-TiO<sub>2</sub>, Li-doped m-TiO<sub>2</sub> (1.0 mg mL<sup>-1</sup>) and laser-treated Li-doped m-TiO<sub>2</sub> films with various laser parameters (b) UPS spectra of the furnace-treated undoped m-TiO<sub>2</sub>, Li doped m-TiO<sub>2</sub> (1.0 mg mL<sup>-1</sup>) and laser-treated Li-doped m-TiO<sub>2</sub> films (800–850 °C) showing  $E_{\text{cut-off}}$  panel and  $E_{\text{on-set}}$  panel, respectively. (c) Energy band diagram and carrier extraction mechanism for the PSCs with furnace-treated undoped m-TiO<sub>2</sub>, Li-doped m-TiO<sub>2</sub> (1.0 mg mL<sup>-1</sup>) and laser-treated Li-doped m-TiO<sub>2</sub> films (800–850 °C).

0.34 and 0.29, respectively, as shown in Table S5 (ESI<sup>†</sup>). Due to a relatively low Li concentration, the Li 1s peak is not distinguishable, as shown in Fig. 4c. However, the Ti 3s peaks at 63.0 eV are observed in these m-TiO<sub>2</sub> films. Notably, the Ti 3s peak intensity for furnace-treated and laser-treated Li-doped m-TiO<sub>2</sub> is stronger than that of the furnace-treated undoped m-TiO<sub>2</sub>, indicating a possible partial Ti<sup>4+</sup> reduction to Ti<sup>3+</sup> in the m-TiO<sub>2</sub> due to presence of Li dopants.<sup>44</sup>

To investigate the crystallinity of the perovskite layer on m-TiO<sub>2</sub> films by different treatments, XRD measurement was carried out. Fig. 4d shows the representative XRD patterns corresponding to Cs<sub>0.1</sub>FA<sub>0.9</sub>PbI<sub>3</sub>, in agreement with the previous studies.<sup>45</sup> All these perovskite films on furnace- and laser-treated m-TiO<sub>2</sub> and Li-doped m-TiO<sub>2</sub> exhibit the  $\alpha$ -phase Cs<sub>0.1</sub>FA<sub>0.9</sub>PbI<sub>3</sub>. We found no obvious change between the perovskite films deposited on furnace-treated undoped

m-TiO<sub>2</sub> and furnace-treated Li-doped m-TiO<sub>2</sub>. Nevertheless, the perovskite deposited on laser-treated Li-doped m-TiO<sub>2</sub> with 800–850 °C and 900–950 °C shows a stronger peak intensity corresponding to the  $\alpha$ -phase, suggesting enhanced crystallinity and quality of the perovskite layers.

To explore the impact of laser treatment and Li doping on the morphology of m-TiO<sub>2</sub> films, SEM was carried out on the top surfaces of different m-TiO<sub>2</sub> films. Fig. S7a–e (ESI<sup>†</sup>) shows the top-view SEM of m-TiO<sub>2</sub> films by different treatments. We observe that the TiO<sub>2</sub> nanoparticles are necked well, as presented in the purple circles. We then carried out SEM to study the surface morphology and grain size of perovskite film deposited on these m-TiO<sub>2</sub> films. All the perovskite films present similar morphology and grain size, as shown in Fig. S8 (ESI<sup>†</sup>). Besides, the cross-section SEM of devices based on these m-TiO<sub>2</sub> films with the configuration of



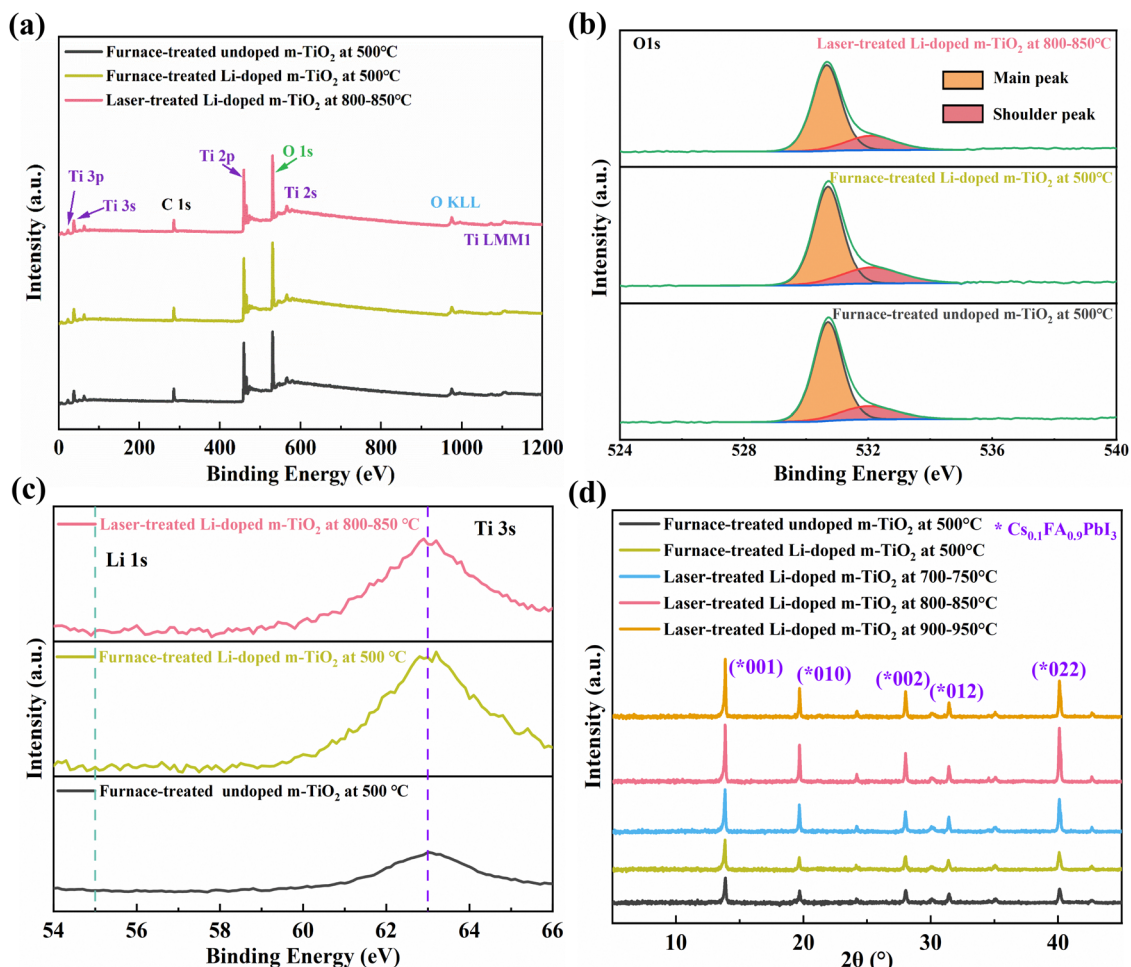


Fig. 4 (a) XPS survey, (b) O 1s and (c) Ti 3s, Li 1s peaks for the furnace-treated undoped m-TiO<sub>2</sub>, Li-doped m-TiO<sub>2</sub> and laser-treated Li-doped m-TiO<sub>2</sub> films. (d) XRD pattern for perovskite films deposited on the furnace-treated undoped m-TiO<sub>2</sub>, Li-doped m-TiO<sub>2</sub> and laser-treated Li-doped m-TiO<sub>2</sub> films.

ITO/ETL/perovskite/HTL/Au was also revealed, as shown in Fig. S9 (ESI<sup>†</sup>).

To evaluate the surface roughness of the ETLs, AFM was carried out on the undoped and Li-doped m-TiO<sub>2</sub> films fabricated by different treatments. Fig. S10 (ESI<sup>†</sup>) presents the root-mean-square roughness (RMS) of these m-TiO<sub>2</sub> films, the furnace-treated undoped m-TiO<sub>2</sub> shows an RMS of 22.44 nm, while the furnace- and laser-treated Li-doped m-TiO<sub>2</sub> films show smoother surfaces with a lower RMS of 18.85 and 16.42 nm, respectively. The smoother surface could improve perovskite deposition, especially for solution deposition methods.<sup>46</sup> This could help reduce the contact resistance and recombination rate between the m-TiO<sub>2</sub>/perovskite interface.<sup>47</sup>

To explore the change of surface wettability, water contact angle measurement was carried out on the undoped and Li-doped m-TiO<sub>2</sub> films fabricated by different treatments. The laser-treated Li-doped m-TiO<sub>2</sub> showed a similar water contact angle of 15.1° compared to 14.4° and 14.7° for the furnace-treated undoped and Li-doped m-TiO<sub>2</sub>, as shown in Fig. S11 (ESI<sup>†</sup>).

To study the bulk trap-state density of these m-TiO<sub>2</sub> films fabricated by different treatments, the dark *I*-*V* curves were

recorded using SCLC with a device configuration of ITO/c-TiO<sub>2</sub>/m-TiO<sub>2</sub>/Au. The *I*-*V* curves could be categorised into three regions by equation ( $J \propto V^n$ ): the ohmic region ( $J \propto V$ ), the trap-free Child's region ( $J \propto V^2$ ), and the trap-filling limited region (TFL) ( $J \propto V^{n \geq 3}$ ).<sup>48</sup> The *I*-*V* curves at a low bias voltage reveal an ohmic contact region with a linear relationship. When the bias voltage increases, the current exhibits a sudden non-linear increase with a steeper slope, demonstrating the trap-filling limited region. Trap-filled limit voltage ( $V_{\text{TFL}}$ ) represents the point at which the transition occurs from the Ohmic regime to the trap-filled limit (TFL) regime. The trap density,  $N_t$ , is obtained by calculating the trap-filled limited voltage through the given equation:<sup>49</sup>

$$N_t = 2V_{\text{TFL}}\epsilon_r\epsilon_0q^{-1}L^{-2} \quad (1)$$

The variables used in this study are as follows:  $V_{\text{TFL}}$  represents the onset voltage of the trap-filled limit region,  $\epsilon_r$  denotes the relative dielectric constant of perovskite (55),  $\epsilon_0$  represents the vacuum permittivity ( $8.854 \times 10^{-12} \text{ F m}^{-1}$ ),  $q$  represents the electron charge ( $1.6 \times 10^{-19} \text{ C}$ ), and  $L$  represents the thickness of the m-TiO<sub>2</sub> film (150 nm).<sup>50</sup> As shown in Fig. 5a, the device



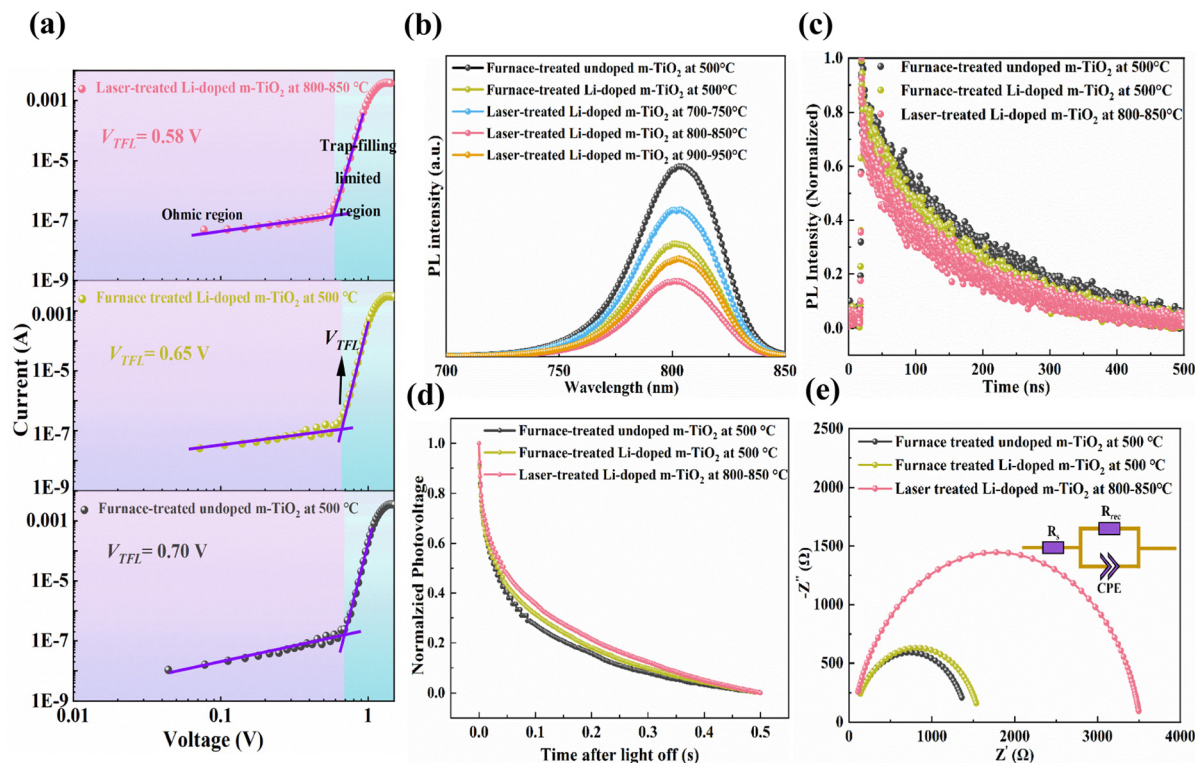


Fig. 5 (a) Dark  $I$ - $V$  curve for the devices with the furnace-treated undoped m-TiO<sub>2</sub>, Li-doped m-TiO<sub>2</sub> and laser-treated Li-doped m-TiO<sub>2</sub> films at 800–850 °C with a structure of ITO/ETL/Au. (b) Steady PL spectra for the perovskite films coated on the furnace-treated undoped m-TiO<sub>2</sub>, Li-doped m-TiO<sub>2</sub> and laser-treated Li-doped m-TiO<sub>2</sub> films. (c) Time-resolved PL curves of the perovskite films coated on furnace-treated undoped m-TiO<sub>2</sub>, Li-doped m-TiO<sub>2</sub> and laser-treated Li-doped m-TiO<sub>2</sub> films (800–850 °C). (d) Transient photo-voltage decay of PSCs based on furnace-treated undoped m-TiO<sub>2</sub>, Li-doped m-TiO<sub>2</sub> and laser-treated Li-doped m-TiO<sub>2</sub> films (800–850 °C). (e) Nyquist plot of devices with furnace-treated undoped m-TiO<sub>2</sub>, Li-doped m-TiO<sub>2</sub> and laser-treated Li-doped m-TiO<sub>2</sub> films (800–850 °C). The inset displays the equivalent circuit for the Nyquist plot.

based on the laser-treated Li-doped m-TiO<sub>2</sub> shows the smallest  $V_{TFL}$  of 0.58, compared to that of the furnace-treated Li-doped and undoped m-TiO<sub>2</sub> film with the  $V_{TFL}$  0.65 V and 0.70 V, respectively. The device based on the laser-treated Li-doped m-TiO<sub>2</sub> also gives the lowest trap densities of  $1.57 \times 10^{17} \text{ cm}^{-3}$ , compared to that of the furnace-treated Li-doped and undoped m-TiO<sub>2</sub> film with the values of  $1.76 \times 10^{17} \text{ cm}^{-3}$  and  $1.89 \times 10^{17} \text{ cm}^{-3}$ , as summarised in Table S6 (ESI<sup>†</sup>). These results indicate that the laser treatment could reduce the trap densities at the perovskite/m-TiO<sub>2</sub> interface, possibly due to a smoother surface and the reduction of the oxygen vacancies during the high-temperature laser treatment in the air that promotes oxygen incorporation into the TiO<sub>2</sub> lattice.<sup>26,51</sup> In addition, these results also indicate that Li doping could effectively passivate the trap state in the m-TiO<sub>2</sub> film. As reported previously, introducing Li dopant into the TiO<sub>2</sub> lattice contributes to a partial reduction of Ti<sup>4+</sup> into Ti<sup>3+</sup>, promoting passivation of the electronic defects due to oxygen vacancies.<sup>35,36</sup>

The electrical conductivity of these m-TiO<sub>2</sub> films fabricated by different treatments could be calculated from  $I$ - $V$  curves at the ohmic region. The conductivity could be determined using the equation:<sup>52</sup>

$$I = \sigma_0 A D^{-1} V \quad (2)$$

where  $\sigma_0$  refers to the electrical conductivity  $A$  refers to the sample's area, and  $D$  refers to the thickness of the mesoporous TiO<sub>2</sub> film. As shown in Fig. S12 (ESI<sup>†</sup>), the laser-treated Li-doped m-TiO<sub>2</sub> shows the highest electrical conductivity of  $1.171 \times 10^{-7} \text{ mS cm}^{-1}$ , compared to that of the furnace-treated Li-doped and undoped m-TiO<sub>2</sub> film with the values of  $0.872 \times 10^{-7} \text{ mS cm}^{-1}$  and  $0.732 \times 10^{-7} \text{ mS cm}^{-1}$ , respectively. This phenomenon is attributed to the enhanced interconnectivity of the TiO<sub>2</sub> nanoparticles and improved crystallinity for the m-TiO<sub>2</sub> prepared by the laser treatment. A higher electron conductivity could enhance electron transport and minimize charge consumption between m-TiO<sub>2</sub> and perovskite, improving the performance of PSCs.<sup>35,53,54</sup>

To further evaluate charge carrier dynamics between the perovskite films deposited on these m-TiO<sub>2</sub> films fabricated by different treatments, the steady-state PL and TRPL measurements were performed with a sample structure of ITO/c-TiO<sub>2</sub>/m-TiO<sub>2</sub>/perovskite. Fig. 5b displays the PL spectra for the perovskite films on the undoped and Li-doped m-TiO<sub>2</sub> films fabricated by different treatments. The sample with furnace-treated Li-doped m-TiO<sub>2</sub> shows stronger PL quenching than furnace-treated undoped m-TiO<sub>2</sub>. In addition, the PL quenching increases first as the laser treatment temperature increases from 700–750 °C to 800–850 °C, followed by a subsequent drop at 900–950 °C. The TRPL plot is fitted according to a bi-exponential decay function, as shown in Fig. 5c.





The calculated proportional fraction and the lifetime are summarised in Table S7 (ESI†). The fast decay  $\tau_1$  is derived from the charge carrier quenching at the interface between m-TiO<sub>2</sub> and perovskite. In contrast, the slow decay  $\tau_2$  is attributed to the radiative recombination of free charge carriers induced by traps in the bulky perovskite.<sup>55</sup> The perovskite deposited on furnace-treated undoped m-TiO<sub>2</sub> exhibits the longest lifetime  $\tau_1$  of 51.34 ns and an average lifetime ( $\tau_{\text{avg}}$ ) of 238.97 ns. In contrast, the perovskite film deposited on the furnace-treated Li-doped m-TiO<sub>2</sub> and laser-treated Li-doped m-TiO<sub>2</sub> (800–850 °C) shows shorter  $\tau_1$  of 50.42 and 31.79 ns, respectively. Besides, they also show the shorter  $\tau_{\text{avg}}$  of 168.54 and 162.59 ns. The shorter  $\tau_1$  and  $\tau_{\text{avg}}$  indicate improved electron transport and minimized charge recombination at the interface between the m-TiO<sub>2</sub> and perovskite due to Li doping and the laser treatment. The TRPL study is consistent with the SCLC measurement, indicating the benefits of laser treatment and Li doping in improving electron transport and passivating the defects of the Li-doped m-TiO<sub>2</sub>.

Notably, when the laser treatment temperature reaches 900–950 °C, perovskite film with Li-doped m-TiO<sub>2</sub> shows a weaker PL quenching effect than 800–850 °C. To understand the reason behind this, the electrical resistance between two ITO electrodes was tested before and after various treatments, as shown in Fig. S13 and Table S8 (ESI†). The rise of ITO resistance could be due to the conversion of large ITO crystals into equiaxed nanograins under a high-temperature treatment.<sup>56</sup> The higher resistance of ITO with laser treatment (900–950 °C) could affect the electron transport, resulting in a weaker PL quenching.

To further investigate the impact of m-TiO<sub>2</sub> films fabricated by different treatments on the recombination dynamics and charge transportation of devices, TPV and TPC measurements were conducted by recording the transient electrical response of PSCs with different m-TiO<sub>2</sub> films. The TPV is used to measure charge recombination under the open-circuit condition. As shown in Fig. 5d, the TPV curve for the device based on the laser-treated Li-doped m-TiO<sub>2</sub> (800–850 °C) presents a slower decay than that of furnace-treated Li-doped and undoped m-TiO<sub>2</sub>, indicating the suppressed charge recombination.<sup>57</sup> Fig. S14 (ESI†) shows the TPC decay for these devices. We noticed that the device based on laser-treated Li-doped m-TiO<sub>2</sub> (800–850 °C) exhibits a faster decay rate than that of the furnace-treated Li-doped and undoped m-TiO<sub>2</sub>, indicating an improved charge transport at the perovskite/m-TiO<sub>2</sub> interface.<sup>32</sup>

The EIS was carried out to further understand the impact of these m-TiO<sub>2</sub> films fabricated by different treatments on the electrical dynamics of PSCs. The corresponding Nyquist plots of devices with furnace-treated m-TiO<sub>2</sub>, furnace- and laser-treated Li-doped m-TiO<sub>2</sub> (800–850 °C) were recorded. The EIS fitting plots of PSCs with the equivalent circuit are presented in Fig. 5e, and the calculated value is summarised in Table S9 (ESI†). The PSCs with the furnace-treated Li-doped m-TiO<sub>2</sub> showed a smaller series resistance ( $R_s$ ) of 44.8  $\Omega$  and larger recombination resistance ( $R_{\text{rec}}$ ) of 1542.0  $\Omega$  than that of the undoped m-TiO<sub>2</sub> with an  $R_s$  of 47.6  $\Omega$  and  $R_{\text{rec}}$  of 1383.0  $\Omega$ . The devices based on the Li-doped m-TiO<sub>2</sub> exhibit the smallest  $R_s$  of

40.4  $\Omega$  and largest series resistance  $R_{\text{rec}}$  of 3477.0  $\Omega$ , indicating that the laser treatment improves charge transport. At the same time, the increased  $R_{\text{rec}}$  suggests that the charge recombination is significantly inhibited at the interface and within the bulk material. These results could be attributed to the change of CBM for the m-TiO<sub>2</sub> by introducing the Li doping and enhanced interconnection of the TiO<sub>2</sub> nanoparticles and interfacial contact between the m-TiO<sub>2</sub> and perovskite by the laser treatment. This will help to improve electron transport and suppress charge recombination at both the interface and bulk, consistent with the findings of the PL and TRPL.

To examine the effects of m-TiO<sub>2</sub> films fabricated by different treatments on the photovoltaic performance, devices with an n-i-p configuration of ITO-glass/c-TiO<sub>2</sub>/m-TiO<sub>2</sub>/perovskite/Spiro-OMeTAD/Au were assembled under a high RH of 60–75%. Fig. 6a illustrates the distribution of PCEs, while Fig. 6b displays the representative  $J$ - $V$  curves. Fig. S15 (ESI†) displays the trends of  $J_{\text{sc}}$ ,  $V_{\text{oc}}$ , and FF, while Table S10 (ESI†) provides an overview of the photovoltaic performance parameters. PSCs utilising furnace-treated Li-doped m-TiO<sub>2</sub> demonstrate an average power conversion efficiency (PCE) of 17.74% and a highest recorded PCE of 18.10%. These cells exhibit a short-circuit current density ( $J_{\text{sc}}$ ) of 23.34 mA cm<sup>-2</sup>, an open-circuit voltage ( $V_{\text{oc}}$ ) of 1.027 V, and a fill factor (FF) of 74.03%. On the other hand, the PCE of the PSCs exhibits an upward trend as the laser annealing temperature is raised from 700–750 °C to 800–850 °C, followed by a decline at 900–950 °C. The PSCs using the laser-treated Li-doped m-TiO<sub>2</sub> at 800–850 °C exhibit optimised photovoltaic performance with an average PCE of 18.48%, and a highest recorded PCE of 19.15%,  $J_{\text{sc}}$  of 23.42 mA cm<sup>-2</sup>,  $V_{\text{oc}}$  of 1.038 V, and a FF of 76.08%. The PCE distribution for the PSCs fabricated using laser-treated Li-doped m-TiO<sub>2</sub> (800–850 °C) and furnace-treated Li-doped m-TiO<sub>2</sub> is presented in Fig. 6c. The improvement of the PCEs by laser treatment could benefit from the boosted electron transport and suppressed charge recombination interconnection of the TiO<sub>2</sub> nanoparticles and interfacial contact at m-TiO<sub>2</sub>/perovskite interface by the laser treatment, which are consistent with the results obtained from Raman, XRD, SCLC, PL, TRPL, and EIS results. Fig. S16 (ESI†) summarises the PCEs for the recent studies on ambient-processed PSCs compared to this work, and Table S11 (ESI†) presents the comparison of laser processing and conditional processing. The external quantum efficiency (EQE) test to confirm the  $J_{\text{sc}}$  of PSCs based on laser-treated Li-doped m-TiO<sub>2</sub> at 800–850 °C, as shown in Fig. 6d. The integrated current density of the devices was calculated to be 21.46 mA cm<sup>-2</sup>, slightly lower than the measured  $J_{\text{sc}}$ .

To understand the impact of mesoscopic structure on the hysteresis behaviour of the device in comparison to the planar device,  $J$ - $V$  curves for PSCs based on mesoscopic and planar structures were measured in reverse and forward scans.

The hysteresis index (HI) was calculated as follows:<sup>50</sup>

$$\text{HI} = \frac{\text{PCE}_{\text{RS}} - \text{PCE}_{\text{FS}}}{\text{PCE}_{\text{RS}}} \quad (3)$$



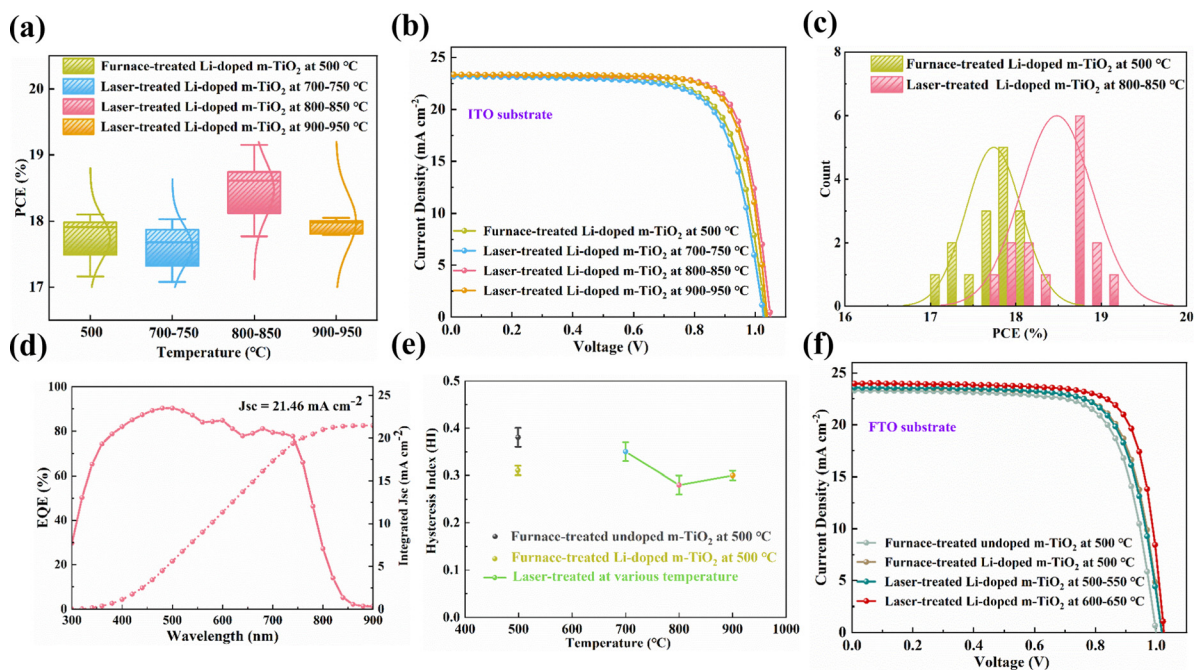


Fig. 6 (a) The PCE distribution and (b) representative  $J$ - $V$  curves for PSCs with furnace- and laser-treated Li-doped  $m$ -TiO<sub>2</sub>/ITO-glass. (c) PCE and counts distribution for PSCs with furnace- and laser-treated Li-doped  $m$ -TiO<sub>2</sub> (800–850 °C). (d) EQE and integrated  $J_{SC}$  of devices with laser-treated Li-doped  $m$ -TiO<sub>2</sub> (800–850 °C). (e) Hysteresis index for the PSCs with furnace-treated undoped  $m$ -TiO<sub>2</sub>, Li-doped  $m$ -TiO<sub>2</sub>, and laser-treated Li-doped  $m$ -TiO<sub>2</sub>. (f) Representative  $J$ - $V$  curves for PSCs with furnace- and laser-treated Li-doped  $m$ -TiO<sub>2</sub>/FTO-glass.

where  $PCE_{RS}$  and  $PCE_{FS}$  are the measures of PCE based on reverse and forward scans, respectively.

As shown in Fig. S17 (ESI<sup>†</sup>), we observed a severe hysteresis behaviour for the PSCs based on  $c$ -TiO<sub>2</sub>. (forward PCE of 7.81% and reverse PCE of 17.08% with a hysteresis index of 0.54). On the other hand, with the addition of  $m$ -TiO<sub>2</sub> and Li-doped  $m$ -TiO<sub>2</sub>, the hysteresis index was remarkably reduced to 0.38, with the lowest hysteresis index achieved by the laser-processed Li-doped  $m$ -TiO<sub>2</sub> (0.28), as shown in Fig. 6e. The corresponding HI are summarised in Table S12 (ESI<sup>†</sup>). Therefore, using a mesoscopic structure significantly suppressed the hysteresis behaviour of our ambient-processed PSCs. We believe this finding is possibly due to a combination of enhanced charge separation and improved perovskite film crystallisation in ambient air with the presence of  $m$ -TiO<sub>2</sub>.<sup>58,59</sup> In addition, the use of  $m$ -TiO<sub>2</sub> can act as a protective layer to reduce the moisture ingress into the perovskite crystals infiltrated within the mesoscopic structure, resulting in enhanced device stability.<sup>60,61</sup> These results further confirmed that the laser treatment could improve electron transport and suppress the charge accumulation and charge recombination occurring at the interface between perovskite and TiO<sub>2</sub>.

To exclude the impact of different treatments on the electrical resistance of the ITO electrodes that could affect the photovoltaic efficiency of PSCs, we further fabricated PSCs on laser-treated  $m$ -TiO<sub>2</sub>/FTO substrates. Fig. S18 (ESI<sup>†</sup>) shows the temperature changes for the Li-doped  $m$ -TiO<sub>2</sub> films coated on FTO-glass by laser processing with the highest annealing temperature of 500–550 and 600–650 °C. The thermal profiles

during the laser processing are displayed in Fig. S19 (ESI<sup>†</sup>), while the parameters are included in Table S2 (ESI<sup>†</sup>). Interestingly, under identical laser processing conditions, the laser treatment of  $m$ -TiO<sub>2</sub> films on ITO-glass results in higher annealing temperatures of 700–750 and 800–850 °C, respectively. This can be attributed to the superior photo-thermal conversion efficiency of ITO in comparison to FTO.<sup>25,62</sup>

The representative  $J$ - $V$  curves for the PSCs with furnace-treated undoped  $m$ -TiO<sub>2</sub>, furnace- and laser-treated Li-doped  $m$ -TiO<sub>2</sub> are shown in Fig. 6f. The device using laser-treated Li-doped  $m$ -TiO<sub>2</sub> (600–650 °C) offers the highest PCE of 18.95% compared to the furnace-treated undoped  $m$ -TiO<sub>2</sub> and Li-doped  $m$ -TiO<sub>2</sub> with 17.01% and 18.10%, respectively. These results further confirmed that the laser treatment could enhance the photovoltaic performance of the PSCs, regardless of whether they are on ITO or FTO substrates.

## 4. Conclusion

In this study, we presented an ultrafast laser process for fabricating Li-doped  $m$ -TiO<sub>2</sub> for mesoscopic PSCs that only needs 42 s laser processing with the highest annealing temperature of 800–850 °C. Not only does the laser process effectively shorten the fabrication time, but it also improves the electron transport ability and suppresses charge recombination and hysteresis behaviour due to the enhanced interconnection between the TiO<sub>2</sub> nanoparticles, reduced oxygen vacancies and improved interfacial contact at the perovskite/ $m$ -TiO<sub>2</sub>.



Consequently, ambient-processed PSCs with laser-treated Li-doped m-TiO<sub>2</sub> showed a champion PCE of 19.15% in contrast with the furnace-treated one of 18.10%. The laser process provides a promising approach to fabricating metal-doped m-TiO<sub>2</sub> films for PSCs and related applications.

## Author contributions

Hongbo Mo: conceptualization, investigation, methodology, data curation, formal analysis, writing – original draft. Qian Chen: conceptualization, methodology, investigation, formal analysis, validation, funding acquisition, supervision, writing – review & editing. Dong Wang: investigation, data curation, writing – review & editing. wei guo: investigation, methodology. Dongxu Cheng: investigation, data curation. Yang Sha: investigation, data curation. Muhamad Z. Mokhtar: investigation, data curation. Zhenyu Jia: investigation, data curation. Janet Jacobs: data curation, formal analysis. Andrew G. Thomas: resources, formal analysis, writing – review & editing. Lin Li: resources, supervision. Zhu Liu: resources, supervision, funding acquisition. Richard J. Curry: formal analysis, resources, funding acquisition, writing – review & editing.

## Conflicts of interest

The authors declare no competing financial interest.

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